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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/774,589	TANABE ET AL.	
Examiner	Art Unit	
DAVID VU	2818	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	296, 663; 765, 787; 769-770	2/5/2005	DV
	773, 935	2/5/2005	DV

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
All	Above	2/5/2005	DV

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY	')
	DATE	EXMR
EAST	2/5/2005	DV
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